

DATA SHEET

74F240

Octal inverter buffer (3-State)

74F241/74F241A

Octal buffer (3-State)

Product data
Supersedes data of 1991 Jan 02

2002 Mar 18

Buffers

74F240/74F241/74F241A

FEATURES

- Octal bus interface
- 3-State buffer outputs sink 64 mA
- 15 mA source current
- Guaranteed output skew less than 2.0 ns (74F241A)
- Reduced ground bounce (74F241A)
- Reduced I_{CC} (74F241A only)
- Reduced loading (74F241A $I_{IL} = 40 \mu A$)

DESCRIPTION

The 74F240 and 74F241 are octal buffers that are ideal for driving bus lines of buffer memory address registers. The outputs are all capable of sinking 64 mA and sourcing up to 15 mA. The device features two output enables, each controlling four of the 3-state outputs.

The 74F241A is functionally equivalent to its non-A counterpart. It has been designed to reduce effects of ground noise. Other advantages are noted in the features.

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F240	4.3 ns	37 mA
74F241	5.0 ns	53 mA
74F241A	4.5 ns	32 mA

ORDERING INFORMATION

DESCRIPTION	ORDER CODE	PKG DWG #
	COMMERCIAL RANGE $V_{CC} = 5 V \pm 10\%$, $T_{amb} = 0^\circ C$ to $+70^\circ C$	
20-pin plastic DIP	N74F240N, N74F241N, N74F241AN	SOT146-1
20-pin plastic SOL	N74F240D, N74F241D, N74F241AD	SOT163-1
20-pin plastic SSOP II	N74F240DB	SOT339-1

INPUT AND OUTPUT LOADING AND FAN OUT TABLE

PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
I _{an} , I _{bn}	Data inputs (74F240)	1.0/1.67	20 μA /1.0 mA
	Data inputs (74F241)	1.0/2.67	20 μA /1.6 mA
	Data inputs (74F241A)	1.0/0.067	20 μA /40 μA
$\overline{OE}a$, $\overline{OE}b$	Output enable inputs (Active-LOW) (74F240)	1.0/0.33	20 μA /0.2 mA
$\overline{OE}a$, $\overline{OE}b$	Output enable input (74F241)	1.0/1.67	20 μA /1.0 mA
	Output enable input (74F241A)	1.0/0.067	20 μA /40 μA
Y _{an} , Y _{bn}	Data outputs (74F241, 74F241A)	750/106.7	15 mA/64 mA
$\overline{Y}a$, $\overline{Y}b$	Data outputs (74F240)	750/106.7	15 mA/64 mA

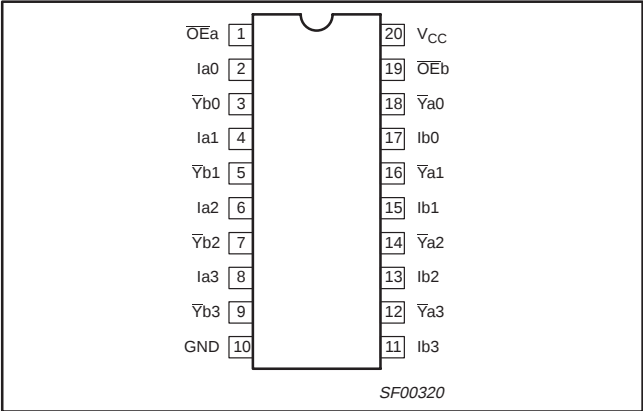
Note to input and output loading and fan out table

One (1.0) FAST unit load is defined as: 20 μA in the HIGH state and 0.6 mA in the LOW state.

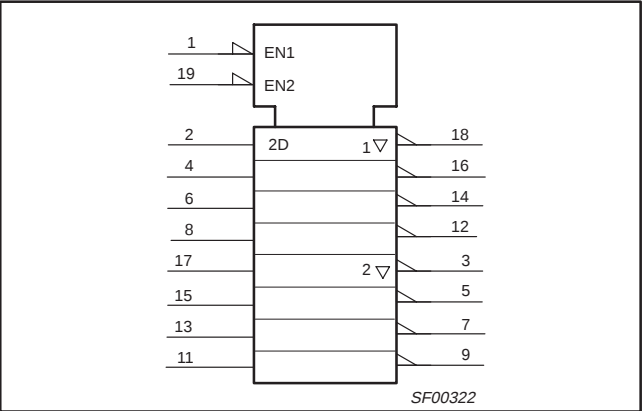
Buffers

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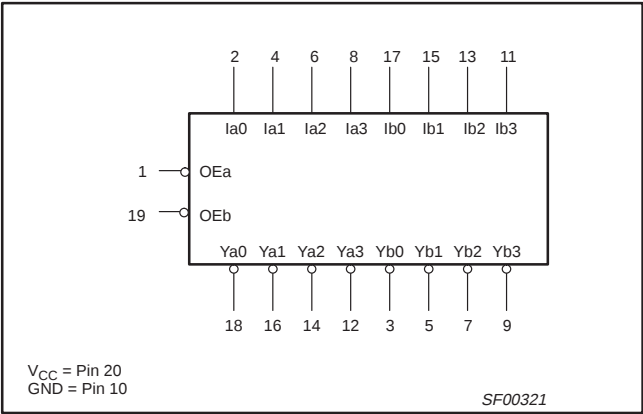
PIN CONFIGURATION FOR 74F240



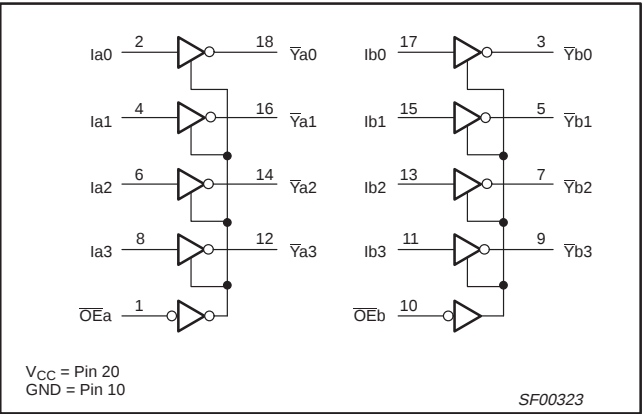
IEC/IEEE SYMBOL FOR 74F240



LOGIC SYMBOL FOR 74F240



LOGIC DIAGRAM FOR 74F240



FUNCTION TABLE FOR 74F240

INPUTS				OUTPUTS	
OEa	Ia	OEb	Ib	Ya	Yb
L	L	L	L	H	H
L	H	L	H	L	L
H	X	H	X	Z	Z

NOTES:

H = High voltage level

L = Low voltage level

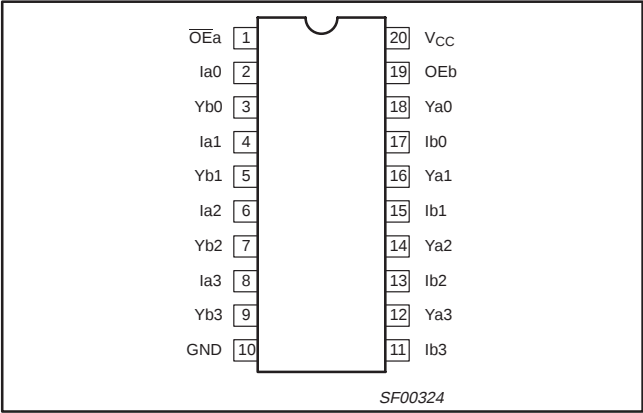
X = Don't care

Z = High impedance "off" state

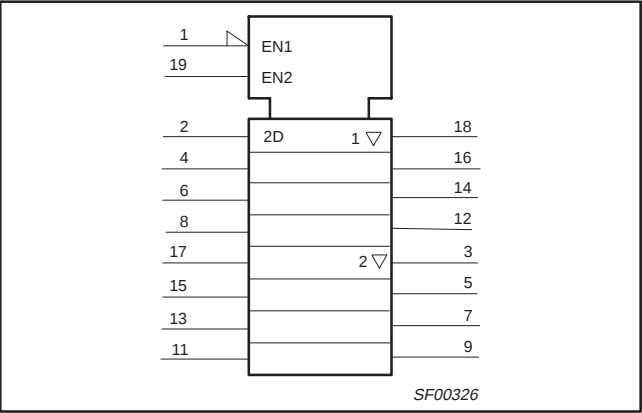
Buffers

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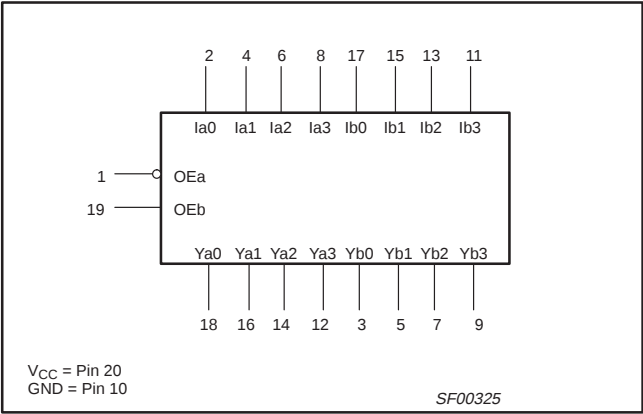
PIN CONFIGURATION FOR 74F241/74F241A



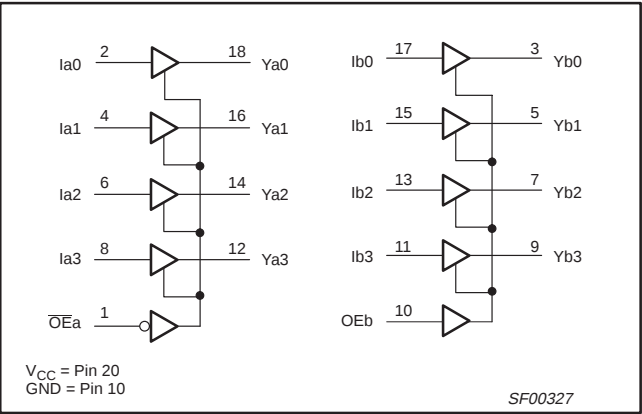
IEC/IEEE SYMBOL FOR 74F241/74F241A



LOGIC SYMBOL FOR 74F241/74F241A



LOGIC DIAGRAM FOR 74F241/74F241A



FUNCTION TABLE FOR 74F241/74F241A

INPUTS				OUTPUTS	
OEa	Ia	OEb	Ib	Ya	Yb
L	L	H	L	L	L
L	H	H	H	H	H
H	X	L	X	Z	Z

NOTES:

H = High voltage level
L = Low voltage level
X = Don't care
Z = High impedance "off" state

Buffers

74F240/74F241/74F241A

ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limit set forth in this table may impair the useful life of the device.

Unless otherwise noted these limits are over the operating free air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	−0.5 to +7.0	V
V _{IN}	Input voltage	−0.5 to +7.0	V
I _{IN}	Input current	−30 to +5	mA
V _{OUT}	Voltage applied to output in high output state	−0.5 to V _{CC}	V
I _{OUT}	Current applied to output in low output state	128	mA
T _{amb}	Operating free air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	−65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS			UNIT
		MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5.0	5.5	V
V _{IH}	High-level input voltage	2.0			V
V _{IL}	Low-level input voltage			0.8	V
I _{IK}	Input clamp current			−18	mA
I _{OH}	High-level output current			−15	mA
I _{OL}	Low-level output current			64	mA
T _{amb}	Operating free air temperature range	0		+70	°C

Buffers

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DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER			TEST CONDITIONS ¹			LIMITS			UNIT
							MIN	TYP ²	MAX	
V _{OH}	High-level output voltage			V _{CC} = MIN; V _{IL} = MAX; V _{IH} = MIN	I _{OH} = −3 mA	±10%V _{CC}	2.4			V
						±5%V _{CC}	2.7	3.4		V
					I _{OH} = −15 mA	±10%V _{CC}	2.0			V
						±5%V _{CC}	2.0			V
V _{OL}	Low-level output voltage			V _{CC} = MIN; V _{IL} = MAX; V _{IH} = MIN	I _{OL} = MAX	±10%V _{CC}			0.50	V
						±5%V _{CC}		0.42	0.50	V
V _{IK}	Input clamp voltage			V _{CC} = MIN; I _I = I _{IK}				−0.73	−1.2	V
I _I	Input current at maximum input voltage			V _{CC} = MAX; V _I = 7.0 V					100	μA
I _{IH}	High-level input current			V _{CC} = MAX; V _I = 2.7 V					20	μA
I _{IL}	Low-level input current	74F240 all inputs		V _{CC} = MAX; V _I = 0.5 V					−1.0	mA
		74F241 $\overline{\text{OE}}$ a, $\overline{\text{OE}}$ b							−1.0	mA
		74F241 I _{an} , I _{bn}							−1.6	mA
		74F241A all inputs							−40	μA
I _{OZH}	Off-state output current, high-level voltage applied			V _{CC} = MAX, V _O = 2.7 V					50	μA
I _{OZL}	Off-state output current, low-level voltage applied			V _{CC} = MAX, V _O = 0.5 V					−50	μA
I _{OS}	Short-circuit output current ³			V _{CC} = MAX			−100		−225	mA
I _{CC}	Supply current (total)	74F240	I _{CCH}	V _{CC} = MAX				12	18	mA
			I _{CCL}					50	70	mA
			I _{CCZ}					35	45	mA
		74F241	I _{CCH}					40	60	mA
			I _{CCL}					60	90	mA
			I _{CCZ}					65	90	mA
		74F241A	I _{CCH}					20	30	mA
			I _{CCL}					49	65	mA
			I _{CCZ}					26	40	mA

NOTES:

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at $V_{CC} = 5 \text{ V}$, $T_{\text{amb}} = 25^\circ\text{C}$.
- Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

Buffers

74F240/74F241/74F241A

AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER		TEST CONDITION	LIMITS					UNIT
				T _{amb} = +25 °C V _{CC} = +5.0 V C _L = 50 pF; R _L = 500 Ω			T _{amb} = 0 °C to +70 °C V _{CC} = +5.0 V ± 10% C _L = 50 pF; R _L = 500 Ω		
				MIN	TYP	MAX	MIN	MAX	
t _{PLH} t _{PHL}	Propagation delay I _{an} , I _{bn} to Y _n	74F240	Waveform 1	3.0 2.0	4.5 3.0	6.5 4.5	3.0 2.0	7.5 5.0	ns
t _{PZH} t _{PZL}	Output enable time to high or low level		Waveform 3 Waveform 4	3.0 4.5	5.0 6.5	7.5 8.5	3.0 4.0	9.0 10.0	ns
t _{PHZ} t _{PLZ}	Output disable time from high or low level		Waveform 3 Waveform 4	3.0 3.0	5.5 5.0	7.0 7.0	3.0 3.0	7.5 7.5	ns
t _{PLH} t _{PHL}	Propagation delay I _{an} , I _{bn} to Y _n	74F241	Waveform 2	2.5 2.5	4.0 4.0	5.2 5.2	2.5 2.5	6.2 6.5	ns
t _{PZH} t _{PZL}	Output enable time to high or low level		Waveform 3 Waveform 4	2.0 2.0	4.0 5.0	5.7 7.0	2.0 2.0	6.7 8.0	ns
t _{PHZ} t _{PLZ}	Output disable time from high or low level		Waveform 3 Waveform 4	2.0 2.0	4.0 4.0	6.0 6.0	2.0 2.0	7.0 7.0	ns
t _{PLH} t _{PHL}	Propagation delay I _{an} , I _{bn} to Y _n	74F241A	Waveform 2	2.5 2.5	4.5 4.5	5.8 5.8	2.5 2.5	6.5 6.5	ns
t _{PZH} t _{PZL}	Output enable time to high or low level		Waveform 3 Waveform 4	2.5 3.5	4.5 5.0	6.0 7.0	2.0 3.0	6.7 8.0	ns
t _{PHZ} t _{PLZ}	Output disable time from high or low level		Waveform 3 Waveform 4	2.0 1.5	4.0 3.5	6.0 5.5	1.5 1.0	6.5 6.0	ns
t _{sk(0)}	Output skew ^{1, 2}		Waveform 5			1.5		2.0	ns

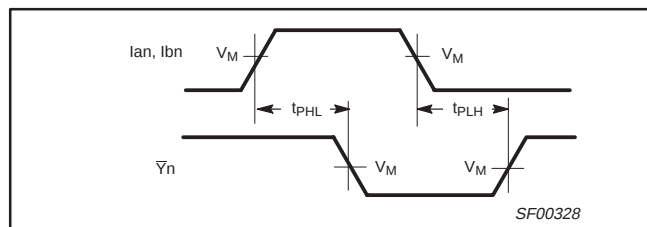
NOTES:

1. | t_{PN} actual – t_{PM} actual | for any output compared to any other output where N and M are either LH or HL.
2. Skew times are valid only under same test conditions (temperature, V_{CC}, loading, etc.).

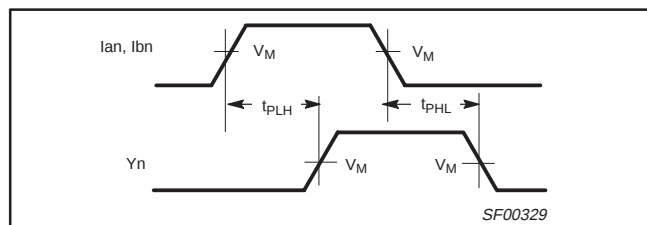
Buffers

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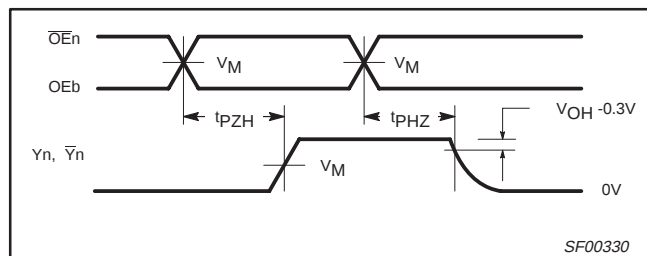
AC WAVEFORMS



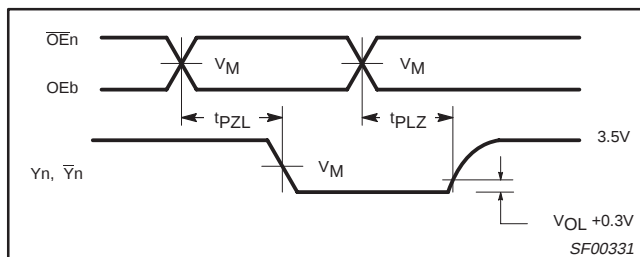
Waveform 1. Propagation delay for inverting outputs



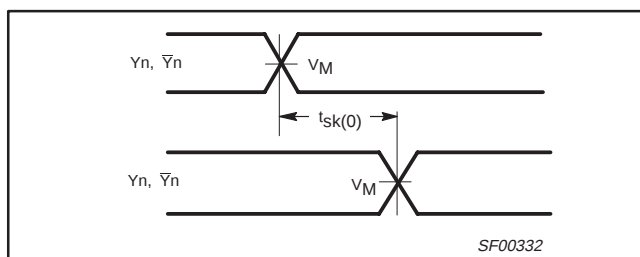
Waveform 2. Propagation delay for non-inverting outputs



Waveform 3. 3-state output enable time to high level and output disable time from high level



Waveform 4. 3-state output enable time to low level and output disable time from low level



Waveform 5. Output skew

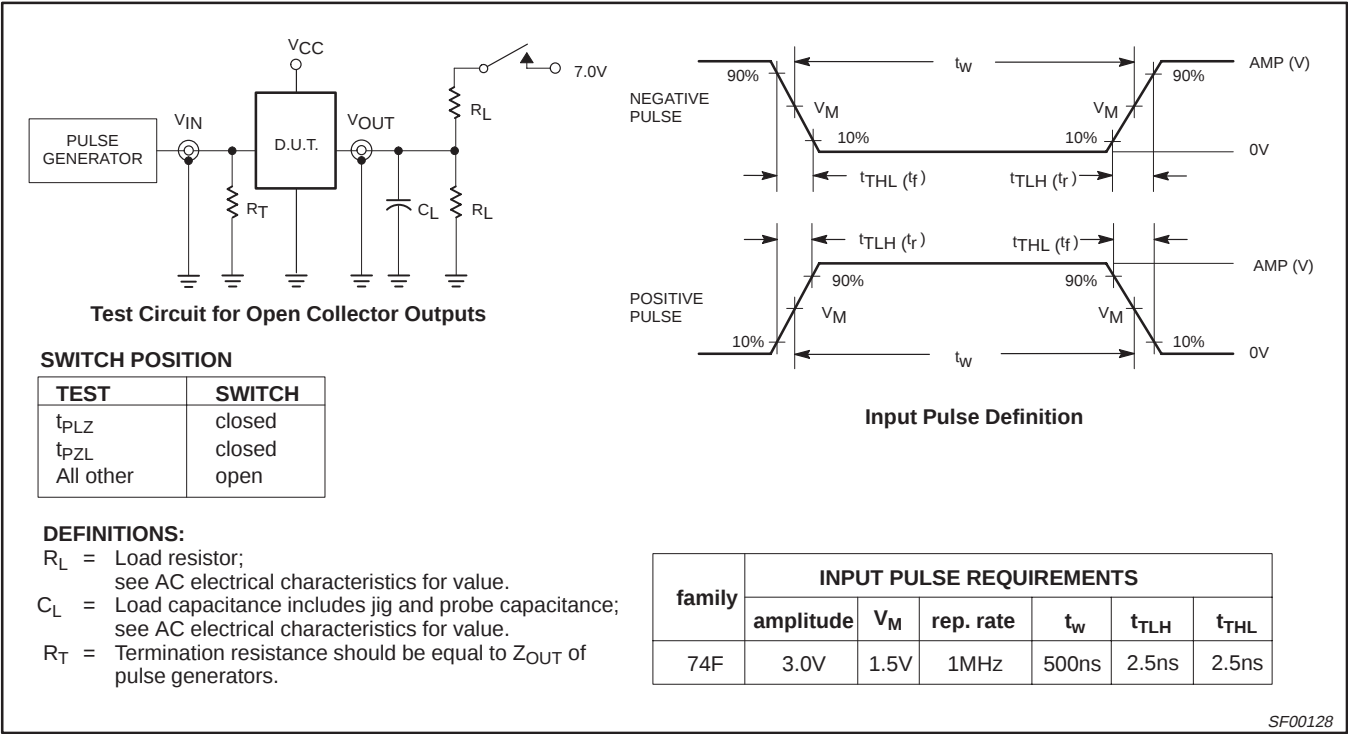
Notes to AC waveforms

1. For all waveforms, $V_M = 1.5$ V.
2. The shaded areas indicate when the input is permitted to change for predictable output performance.

Buffers

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TEST CIRCUIT AND WAVEFORMS



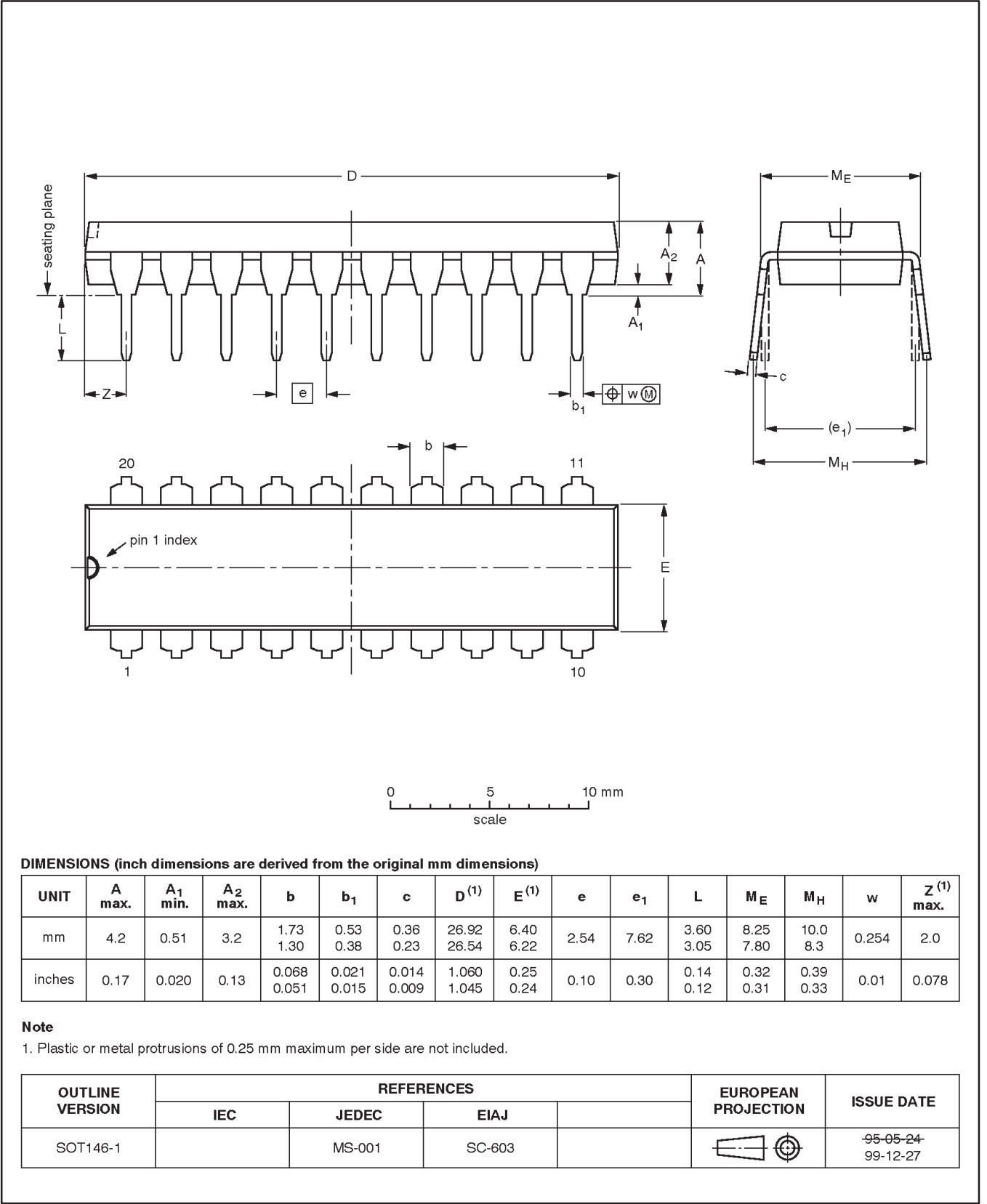
SF00128

Buffers

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DIP20: plastic dual in-line package; 20 leads (300 mil)

SOT146-1

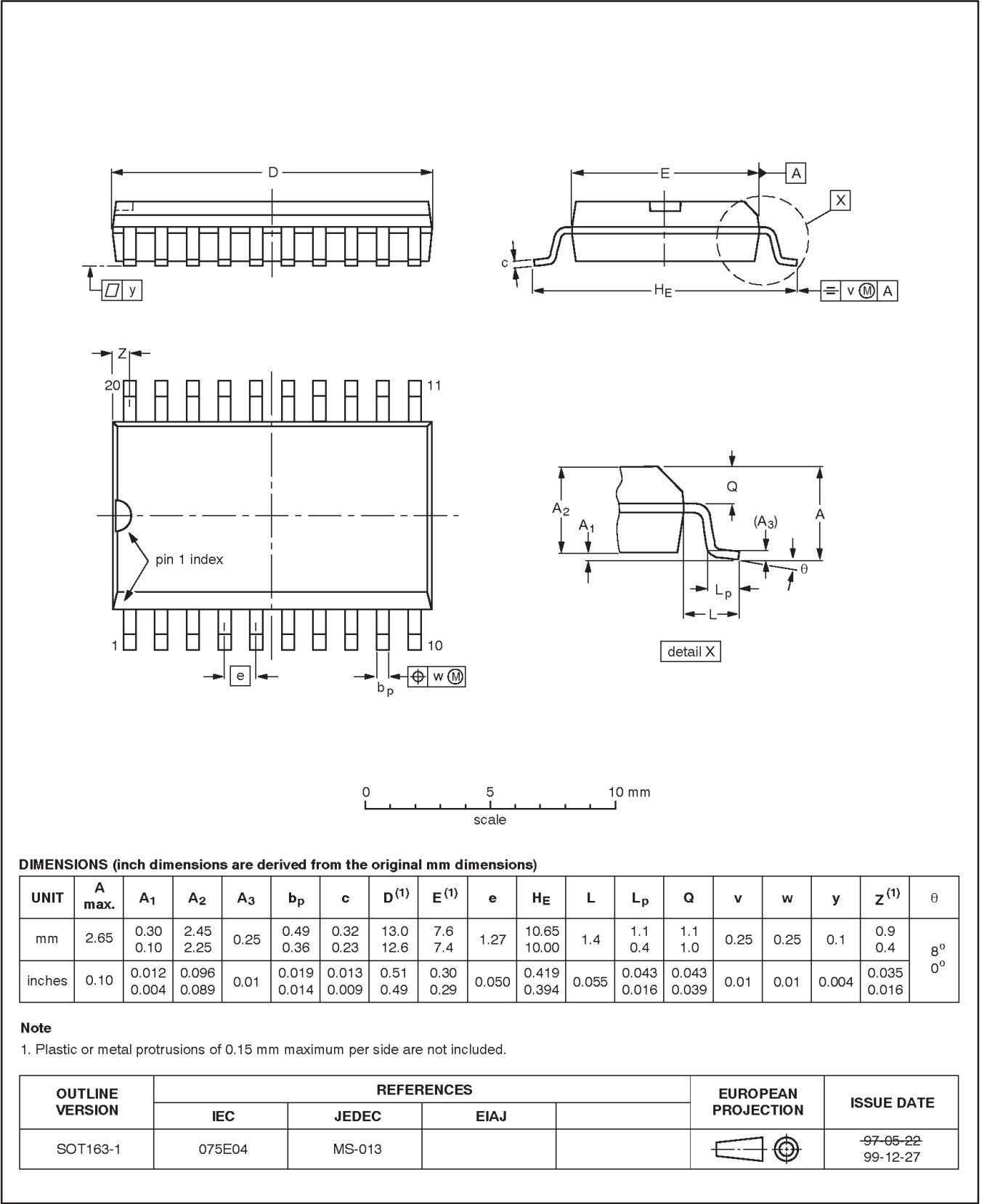


Buffers

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SO20: plastic small outline package; 20 leads; body width 7.5 mm

SOT163-1

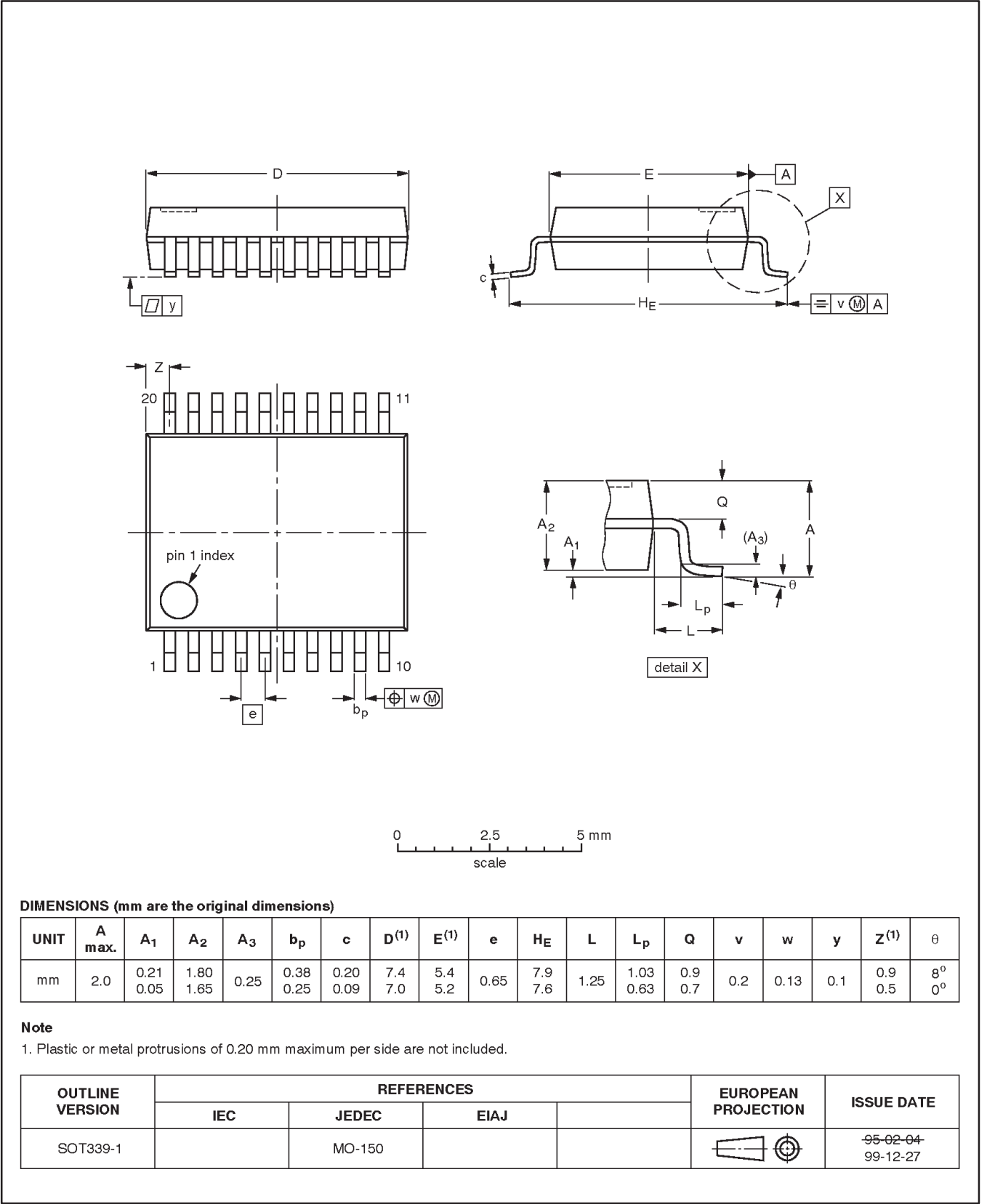


Buffers

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SSOP20: plastic shrink small outline package; 20 leads; body width 5.3 mm

SOT339-1



Buffers**74F240/74F241/74F241A**

NOTES

Buffers

74F240/74F241/74F241A

Data sheet status

Data sheet status ^[1]	Product status ^[2]	Definitions
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

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